

# STP4NK60Z, STP4NK60ZFP

# N-channel 600 V, 1.7 Ω typ., 4 A Zener-protected SuperMESH™ Power MOSFETs in TO-220 and TO-220FP packages

Datasheet - production data

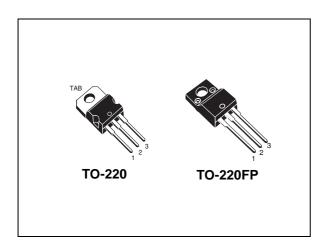
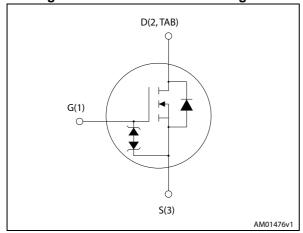


Figure 1. Internal schematic diagram



### **Features**

Order codes	V <sub>DS</sub>	R <sub>DS(on) max</sub> .	P <sub>TOT</sub>	I <sub>D</sub>
STP4NK60Z	600 V	20	70 W	4 A
STP4NK60ZFP		212	70 VV	4 A

- 100% avalanche tested
- Very low intrinsic capacitances
- Zener-protected

## **Applications**

· Switching applications

## **Description**

These devices are N-channel Zener-protected Power MOSFETs developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well established strip-based PowerMESH™ layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

Table 1. Device summary

Order codes	Marking	Packages	Packaging	
STP4NK60Z	P4NK60Z	TO-220	Tube	
STP4NK60ZFP	P4NK60ZFP	TO-220FP	Tube	

## **Contents**

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuits
4	Package mechanical data
5	Revision history1

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value		Unit	
Symbol	Parameter	TO-220	TO-220FP	Onit	
V <sub>DS</sub>	Drain-source voltage	60	600		
V <sub>GS</sub>	Gate- source voltage	±	30	V	
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C 4 4 <sup>(1)</sup>			Α	
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C		2.5 <sup>(1)</sup>	Α	
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)		16 <sup>(1)</sup>	Α	
P <sub>TOT</sub>	P <sub>TOT</sub> Total dissipation at T <sub>C</sub> = 25 °C		25	W	
	Derating factor	0.56	0.2	W/°C	
ESD	Gate-source human body model (C=100 pF, R=1.5 $k\Omega$ )	3		kV	
dv/dt (3)	Peak diode recovery voltage slope	4.5		V/ns	
V <sub>ISO</sub>	V <sub>ISO</sub> Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T <sub>C</sub> =25 °C)		V		
T <sub>stg</sub>	Storage temperature	-55 to 150		°C	
T <sub>j</sub>	Max operating junction temperature	15	Max operating junction temperature 150		

- 1. Limited by maximum junction temperature.
- 2. Pulse width limited by safe operating area
- 3.  $I_{SD} \leq$  4 A, di/dt  $\leq$  200 A/ $\mu$ s,  $V_{DD} \leq$   $V_{(BR)DSS}$ ,  $T_{J} \leq$   $T_{JMAX}$ .

Table 3. Thermal data

Ī	Compleal	Donometer	Va		l lmit
Symbol Parameter		Parameter	TO-220	TO-220FP	Unit
	R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	5	°C/W
	R <sub>thj-amb</sub>	Thermal resistance junction-ambient max 62.5		2.5	°C/W

**Table 4. Avalanche characteristics** 

	Symbol	Parameter	Value	Unit	
$I_{AR}$ Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{j \text{ max}}$ )		4	Α		
	E <sub>AS</sub> Single pulse avalanche energy (starting $T_J = 25 ^{\circ}\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50 \text{V}$ )		120	mJ	

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> =1 mA	600			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 600 V V <sub>DS</sub> = 600 V, T <sub>C</sub> = 125 °C			1 50	μA μA
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 50 \mu\text{A}$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$		1.7	2	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 2 \text{ A}$	-	3		S
C <sub>iss</sub>	Input capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0	-	510		pF
C <sub>oss</sub>	Output capacitance		-	67		pF
C <sub>rss</sub>	Reverse transfer capacitance	VGS - V	-	13		pF
C <sub>oss eq.</sub> (2)	Equivalent output capacitance	V <sub>DS</sub> =0, V <sub>DS</sub> = 0 to 480 V	-	38.5		pF
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_{D} = 2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 17)	-	12		ns
t <sub>r</sub>	Rise time		-	9.5		ns
t <sub>d(off)</sub>	Turn-off delay time		-	29		ns
t <sub>f</sub>	Fall time		-	16.5		ns
t <sub>r(Voff)</sub>	Off-voltage rise time	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4 A,	-	12		ns
t <sub>r</sub>	Fall time	$R_G = 4.7 \Omega, V_{GS} = 10 V$	-	12		ns
t <sub>c</sub>	Cross-over time	(see Figure 19)	-	19.5		ns
Qg	Total gate charge	$V_{DD} = 480 \text{ V}, I_{D} = 4 \text{ A},$ $V_{GS} = 10 \text{ V}$	-	18.8	26	nC
Q <sub>gs</sub>	Gate-source charge		-	3.8		nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 18)	-	9.8		nC

<sup>1.</sup> Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

<sup>2.</sup>  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .



**Symbol Parameter Test conditions** Min. Typ. Max. Unit Source-drain current 4 Α  $I_{SD}$  $I_{SDM}^{(1)}$ Source-drain current (pulsed) 16 Α V<sub>SD</sub><sup>(2)</sup> ٧ Forward on voltage  $I_{SD} = 4 A$ ,  $V_{GS} = 0$ -1.6  $\mathsf{t}_{\mathsf{rr}}$ -400 Reverse recovery time ns  $I_{SD} = 4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$  $V_{DD}$  = 24 V, Tj = 150 °C 1700  $Q_{rr}$ Reverse recovery charge nC (see Figure 19) Reverse recovery current 8.5 Α  $I_{RRM}$ 

Table 7. Source drain diode

Table 8. Gate-source Zener diode

	Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
ĺ	$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{mA}, I_D = 0$	30	-	-	V

The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.



<sup>1.</sup> Pulsed: pulse duration =  $300 \mu s$ , duty cycle 1.5%

<sup>2.</sup> Pulse width limited by safe operating area

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

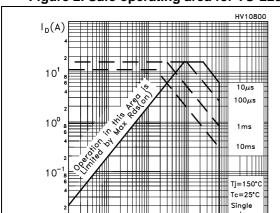


Figure 3. Thermal impedance for TO-220

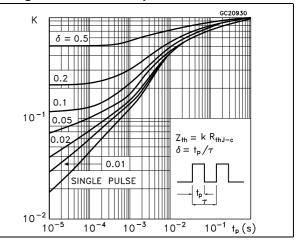


Figure 4. Safe operating area for TO-220FP

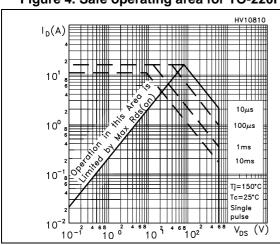


Figure 5. Thermal impedance for TO-220FP

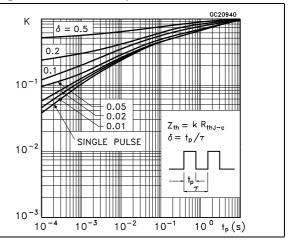


Figure 6. Output characteristics

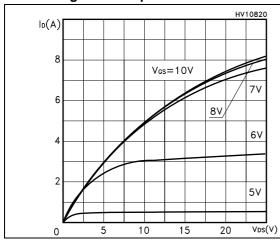
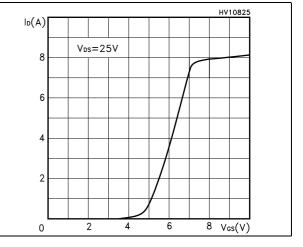


Figure 7. Transfer characteristics



577

6/16 DocID025020 Rev 2

Figure 8. Transconductance

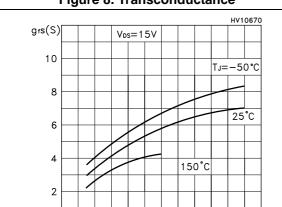


Figure 9. Static drain-source on-resistance

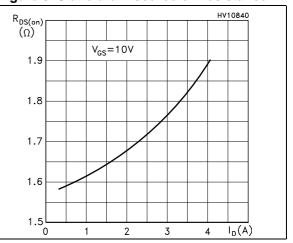


Figure 10. Gate charge vs gate-source voltage

6

I<sub>D</sub>(A)

2

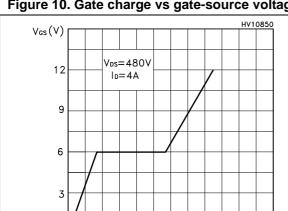


Figure 11. Capacitance variations

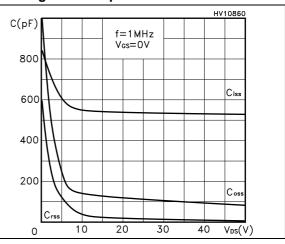


Figure 12. Normalized gate threshold voltage vs temperature

15

20

25 Qg(nC)

10

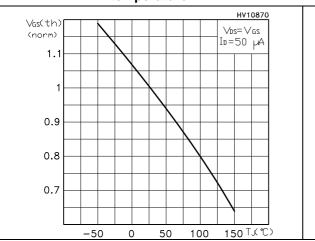


Figure 13. Normalized R<sub>DS(on)</sub> vs temperature

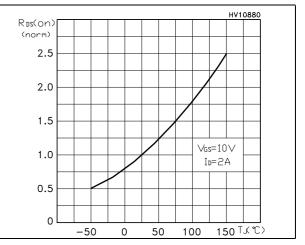
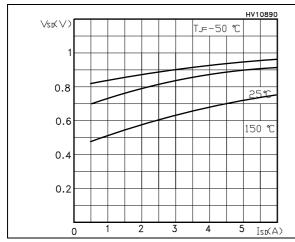


Figure 14. Source-drain diode forward characteristic

Figure 15. Normalized  $V_{DS}$  vs temperature



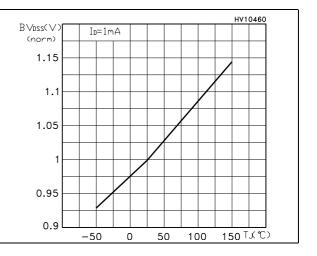
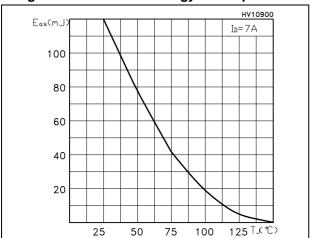


Figure 16. Avalanche energy vs temperature



## 3 Test circuits

Figure 17. Switching times test circuit for resistive load

Figure 18. Gate charge test circuit

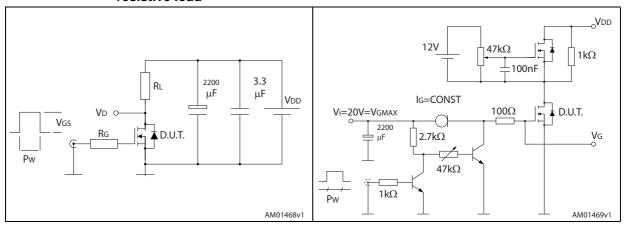


Figure 19. Test circuit for inductive load switching and diode recovery times

Figure 20. Unclamped inductive load test circuit

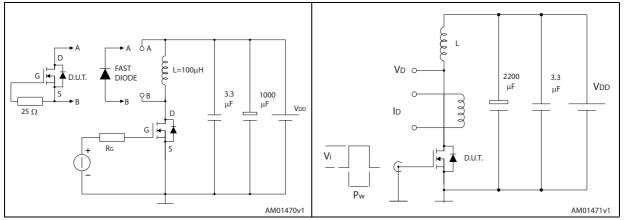
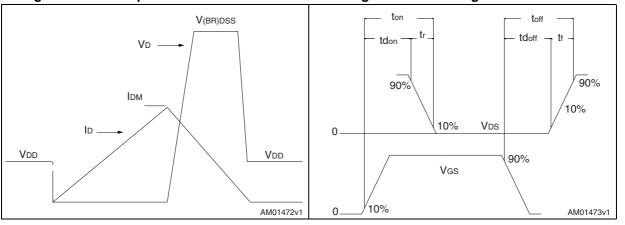


Figure 21. Unclamped inductive waveform

Figure 22. Switching time waveform



# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



øΡ Ε H1 D <u>D1</u> L20 L30 b1(X3) -- b (X3) \_e1\_\_\_ 0015988\_typeA\_Rev\_T

Figure 23. TO-220 type A drawing

Table 9. TO-220 type A mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1-7012510\_Rev\_K\_B

Figure 24. TO-220FP drawing

Table 10. TO-220FP mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

# 5 Revision history

**Table 11. Document revision history** 

Date	Revision	Changes
19-Jul-2013	1	First release. Part numbers previously included in datasheet DocID8882
22-Jan-2014	2	<ul><li>Modified: figure in cover page</li><li>Minor text changes</li></ul>

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16/16 DocID025020 Rev 2

